

INTERNATIONAL STANDARD

IEC
61300-3-30

First edition
2003-01

**Fibre optic interconnecting devices
and passive components –
Basic test and measurement procedures –**

**Part 3-30:
Examinations and measurements –
Polish angle and fibre position
on single ferrule multifibre connectors**

*Dispositifs d'interconnexion et composants passifs
à fibres optiques –
Méthodes fondamentales d'essais et de mesures –*

*Partie 3-30:
Examens et mesures –
Angle de la face polie et position de la fibre sur
l'embout des connecteurs multifibres*



Reference number
IEC 61300-3-30:2003(E)

Publication numbering

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CONTENTS

FOREWORD	3
1 Scope	5
2 Normative references	5
3 General description	5
4 Apparatus	6
4.1 Ferrule holder	6
4.2 Positioning stage	6
4.3 Three-dimensional interferometry	6
5 Procedure	7
5.1 Measurement regions	7
5.2 Method for analysis	9
6 Details to be specified	11
Annex A (informative) Formula for calculating end face geometry	13
Annex B (normative) Surface angle sign convention (shown graphically)	14
Annex C (normative) Fibre counting convention (shown graphically)	15
Bibliography	16
Figure 1 – Three-dimensional interferometry analyser	7
Figure 2 – Measurement regions on ferrule	8
Figure 3 – Multimode fibre core dip regions	8
Table 1 – Ferrule measurement areas	12
Table 2 – Multimode core dip areas	12

INTERNATIONAL ELECTROTECHNICAL COMMISSION

FIBRE OPTIC INTERCONNECTING DEVICES AND PASSIVE COMPONENTS – BASIC TEST AND MEASUREMENT PROCEDURES –

Part 3-30: Examinations and measurements – Polish angle and fibre position on single ferrule multifibre connectors

FOREWORD

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International Standard IEC 61300-3-30 has been prepared by subcommittee 86B: Fibre optic interconnecting devices and passive components, of IEC technical committee 86: Fibre optics.

The text of this standard is based on the following documents:

FDIS	Report on voting
86B/1747/FDIS	86B/1773/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 3.

IEC 61300 consists of the following parts, under the general title *Fibre optic interconnecting devices and passive components – Basic test and measurement procedures*:

- Part 1: General and guidance
- Part 2: Tests
- Part 3: Examinations and measurements

The committee has decided that the contents of this publication will remain unchanged until 2007. At this date, the publication will be

- reconfirmed;
- withdrawn;
- replaced by a revised edition, or
- amended.

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FIBRE OPTIC INTERCONNECTING DEVICES AND PASSIVE COMPONENTS – BASIC TEST AND MEASUREMENT PROCEDURES –

Part 3-30: Examinations and measurements – Polish angle and fibre position on single ferrule multifibre connectors

1 Scope

This part of IEC 61300 describes a procedure to assess end face geometry in guide pin based multifibre ferrules and connectors. The primary attributes are fibre position relative to the end face, either undercut or protrusion, end face angle relative to the guide pin bores, and core dip for multimode fibres.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

None.

3 General description

Guide pin based multifibre connectors typically have a rectangular end face with a long axis and a short axis. Ideally a flat polish is desired on the end face with the fibres protruding slightly and all in the same plane to assure physical contact of the fibre cores when two connectors are intermated. In practice, the end face typically has two different curvatures across the surface along the long and short axis. Since mated ferrules are aligned by pins in the guide holes, the end face of the ferrule must be properly oriented (X and Y angle) with respect to the guide holes to achieve positive contact. The end face angle in the X-axis and the end face angle in the Y-axis are measured by finding the best fit plane based on a percentage of the highest points in a specified region of interest. The highest points typically show the greatest modulation from an interferometric standpoint. This allows for more robust measurements and greater repeatability between different interferometers.

The angle of the best fit plane is calculated by comparing it to the reference plane which is perpendicular to the axis of each guide hole. The fibre protrusion, $(+p)$, or undercut, $(-p)$, of the fibres is a planar height defined as the distance between the fibre end face and the best fit planar surface previously described. Core dip is specific to multimode fibres because the large core is softer than the edge of the fibre and tends to polish away faster. Core dip is calculated by subtracting the average height of the core area from the average height of an annular area near the edge of the fibre.

One method is described for this procedure. Analysing the endface with a three-dimensional interferometry type surface analyser.